

Notice of References Cited

Application/Control No.

10/540,220

Applicant(s)/Patent Under
Reexamination
DISCHAMP ET AL.

Examiner

DANIEL WALSH

Art Unit

2887

Page 1 of 3

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Notice of References Cited	Application/Control No. 10/540,220		Applicant(s)/Patent Under Reexamination DISCHAMP ET AL.	
	Examiner DANIEL WALSH		Art Unit 2887	Page 2 of 3

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	Examiner DANIEL WALSH		Art Unit 2887	Page 3 of 3

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	K	US-			
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